



DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _A = +25°C
30V	3Ω @ V_{GS} = 4.5 V	350 mA
307	7Ω @ V_{GS} = 2.5 V	350 IIIA

Description

This MOSFET has been designed to minimize the on-state resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Motor Control
- Power Management Functions
- DC-DC Converters
- Backlighting

Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- ESD Protected Gate to 2kV
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

Mechanical Data

- Case: SOT563
- Case Material: Molded Plastic, "Green" Molding Compound UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.006 grams (approximate)







Top View

Equivalent Circuit

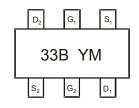
Ordering Information (Note 4)

Part Number	Case	Packaging
DMN33D8LV-7	SOT563	3K/Tape & Reel
DMN33D8LV-13	SOT563	10K/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



33B = Product Type Marking Code YM = Date Code Marking Y = Year ex: V = 2008 M = Month ex: 9 = September

Date Code Key

Year	201	1	2012		2013	20	14	2015		2016	2	2017
Code	Υ		Z		Α	[3	С		D		E
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Drain-Source Voltage	V_{DSS}	30	V	
Gate-Source Voltage	V_{GSS}	±20	V	
Continuous Drain Current (Note 5) $V_{GS} = 4.5V$ Steady $T_A = +25^{\circ}C$ State $T_A = +70^{\circ}C$		I _D	350 200	mA
Maximum Continuous Body Diode Forward Current	(Note 5)	I _S	0.5	Α
Pulsed Drain Current (10µs pulse, duty cycle=1%)		I _{DM}	0.8	Α

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Total Dawer Dissination (Note 5)	T _A = +25°C	0	0.43	W	
Total Power Dissipation (Note 5)	T _A = +70°C	P_{D}	0.20		
Thermal Resistance, Junction to Ambient (Note 5)	$R_{\theta JA}$	288	°C/W		
Operating and Storage Temperature Range	$T_{J,}T_{STG}$	-55 to 150	°C		

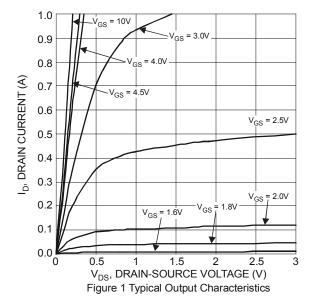
$\textbf{Electrical Characteristics} \ (@T_A = +25^{\circ}C, \ unless \ otherwise \ specified.)$

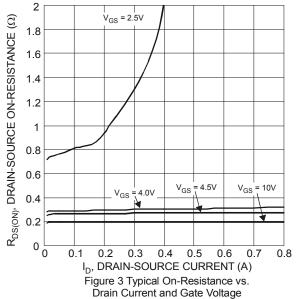
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 6)							
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V$, $I_D = 1mA$	
Zero Gate Voltage Drain Current @T _C = +25°C	I _{DSS}	_	_	1	μA	V _{DS} = 30V, V _{GS} = 0V	
Gate-Source Leakage	I _{GSS}	_	_	±10	μΑ	V _{GS} = ±16V, V _{DS} = 0V	
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V _{GS(th)}	0.8	_	1.5	V	$V_{DS} = 3V$, $I_D = 100 \mu A$	
		_	_	2.4		V _{GS} = 10V, I _D = 250mA	
Static Drain-Source On-Resistance	_	_	_	3.0	Ω	V _{GS} = 4.5V, I _D = 250mA	
Static Drain-Source On-Resistance	R _{DS(ON)}	_	_	5.0	12	V _{GS} = 4.0V, I _D = 10mA	
		_	_	7.0		V _{GS} = 2.5V, I _D = 10mA	
Forward Transfer Admittance	Y _{fs}	10	_	-	mS	$V_{DS} = 3V, I_{D} = 10mA$	
Diode Forward Voltage	V_{SD}	_	_	1.2	V	V _{GS} = 0V, I _S = 115mA	
DYNAMIC CHARACTERISTICS (Note 7)							
Input Capacitance	C _{iss}	_	48	_	pF		
Output Capacitance	Coss	_	11	_	pF	V _{DS} = 5V, V _{GS} = 0V, f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	_	8	_	pF	1 - 1.0Wii 12	
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	0.55	_	nC		
Total Gate Charge (V _{GS} = 10V)	Qg	_	1.23	_	nC	$V_{GS} = 10V, V_{DS} = 10V,$	
Gate-Source Charge	Qgs	_	0.14	_	nC	I _D = 250mA	
Gate-Drain Charge	Q _{gd}	_	0.14	_	nC		
Turn-On Delay Time		_	2.9	_	ns		
Turn-On Rise Time		_	2.6	_	ns	V _{DD} = 30V, V _{GS} = 10V,	
Turn-Off Delay Time		_	18.2	_	ns	$R_G = 25\Omega$, $I_D = 200 \text{mA}$	
Turn-Off Fall Time			13.6	_	ns		

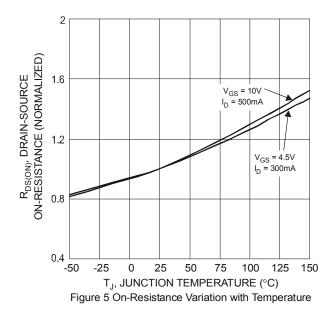
5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

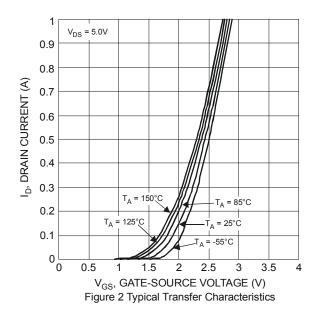
Short duration pulse test used to minimize self-heating effect.
Guaranteed by design. Not subject to product testing.

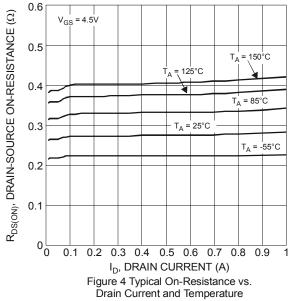


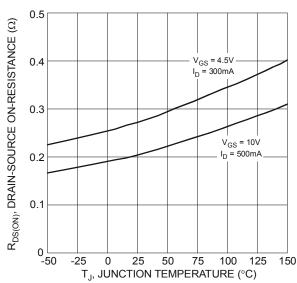














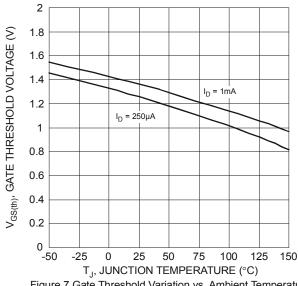
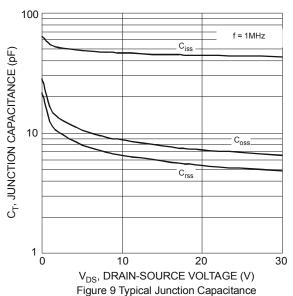
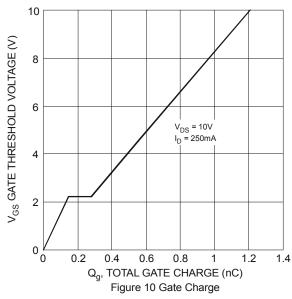
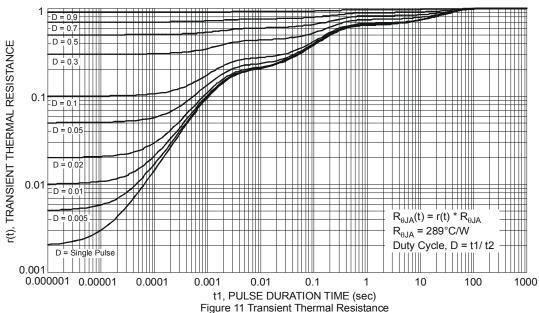


Figure 7 Gate Threshold Variation vs. Ambient Temperature



1 0.9 0.8 I_S, SOURCE CURRENT (A) 0.7 0.6 = 150°C 0.5 0.4 0.3 0.2 T_A = -55°C 0.1 0 0 0.3 0.6 0.9 1.2 1.5 V_{SD}, SOURCE-DRAIN VOLTAGE (V) Figure 8 Diode Forward Voltage vs. Current

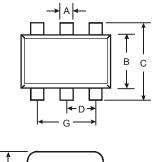


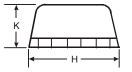


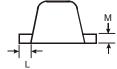


Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



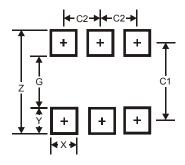




SOT563							
Dim	Min	Max	Тур				
Α	0.15	0.30	0.20				
В	1.10	1.25	1.20				
С	1.55	1.70	1.60				
D	-	-	0.50				
G	0.90	1.10	1.00				
Н	1.50	1.70	1.60				
K	0.55	0.60	0.60				
L	0.10	0.30	0.20				
M	0.10	0.18	0.11				
All	All Dimensions in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	2.2
G	1.2
Х	0.375
Y	0.5
C1	1.7
C2	0.5



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